

Notice of References Cited	Application/Control No. 10/642,521	Applicant(s)/Patent Under Reexamination SHIMURA ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,181,888	01-2001	Scheuer et al.	399/49
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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